

Notice of References Cited

Application/Control No.

10/041,601

Applicant(s)/Patent Under

Reexamination

NAKAI ET AL.

Examiner

Thinh T Nguyen

Art Unit

2818

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-5,325,336	06-1994	Tomishima et al.	365/207
*	C	US-5,629,887	05-1997	Nakano et al.	365/51
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	M	US-			

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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